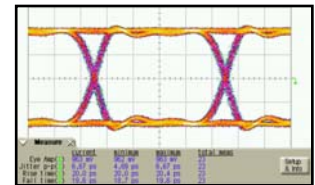
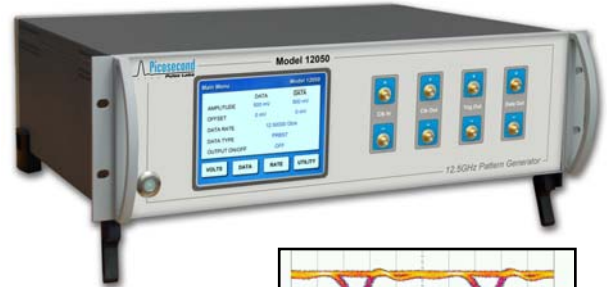


Features:

- Available in 8Gb/s (Model 12040) and 12.5Gb/s (Model 12050) versions
- Programmable data rate, amplitude, offset, and crossing point
- Differential data, pattern trigger, clock/n, and full rate clock outputs
- Built-in random and sinusoidal jitter insertion option
- PRBS and user defined patterns
- Single bit error insertion for testing error measurement setups
- Front panel touch screen GUI or USB computer control

PatternPro™ Line of
 Serial Data Test Instruments



Output Performance:

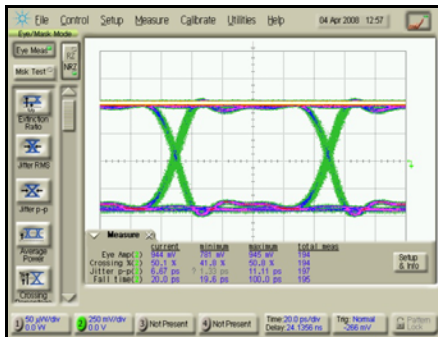
- 25ps typical 10% to 90% rise/fall times
- 250mV to 2.0V output amplitude
- -2.0V to 3.0V offset window
- 35% to 65% programmable crossing point

Applications:

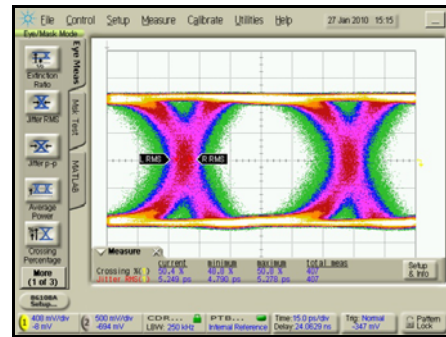
- High-speed serial data testing
- Semiconductor device and component testing
- R&D design verification

The Picosecond Pulse Labs' **SDG Model 12040** and **SDG Model 12050** are high performance, fully programmable instruments. These pattern generators feature high-performance DC coupled limiting amplifiers that result in accurate, fast risetime data signals. In addition, the 12040 and 12050 provide many useful test features such as a **built-in jitter insertion option** and single bit error injection.

DC coupled output with consistent performance across all amplitude, offset, and data conditions. Built-in programmable jitter insertion option for flexible stressed eye testing.



Accurate eye diagram at 87.5% mark density ratio.



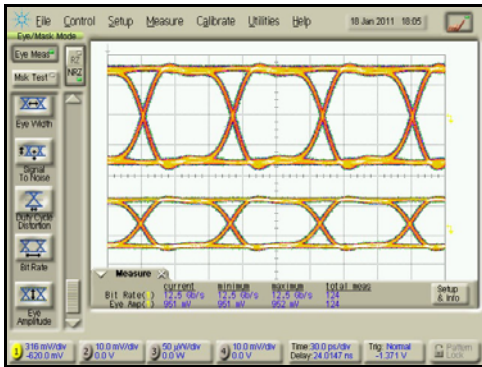
Stressed eye with built-in random jitter insertion.

Specifications:

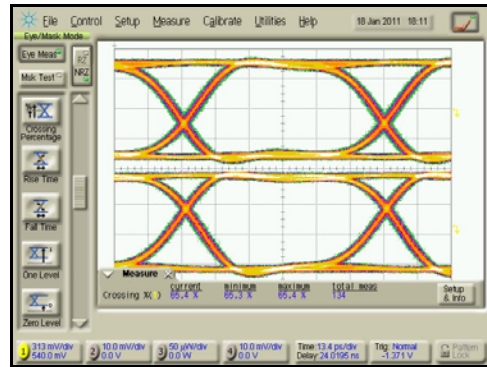
Description:	Value/Details	Notes
Data Outputs:		<i>Differential/complimentary output.</i>
Amplitude Single ended Differential	250mV to 2.0V 500mV to 4.0V	<i>Positive and negative differential outputs are independently programmable.</i>
Offset	-2.0V to +3.0V window	<i>Programmable/adjustable</i>
Termination Voltage	-2.0V to +3.3V	<i>Programmable/adjustable</i>
Crossing point adjust range	35% to 65% typ.	<i>Programmable/adjustable</i>
Risetime 20% to 80% 10% to 90%	17 ps typ. 25 ps typ.	
Total Jitter	1 ps RMS typ.	Measured with 2 ⁷ -1 PRBS.
Output impedance	50 Ω single ended	100 Ω differential
Other Outputs:		
Trigger/Divided Clk	Swings from -600mV to 0V	<i>User selectable as pattern trigger or clock/n (user selected n). DC coupled.</i>
Clock signal Amplitude Jitter	400mVpp typ. <1 ps RMS typ.	<i>AC coupled</i>
Inputs:		
External clock input	400mVpp typ. 1Vpp max	<i>AC coupled. Operates over range of 6.25GHz to 12.5GHz.</i>
Pattern Generator:		
Data rate Model 12040 Model 12050	500 Mb/s to 8 Gb/s 800 Mb/s to 12.5 Gb/s	<i>Data rate is programmable from front panel or computer control.</i>
Frequency resolution	10kHz	
Built-in PRBS patterns	2 ⁿ -1	<i>n = 7, 15, 23, 31</i>
User defined pattern depth	512 kbit	
Single bit error injection	Yes	
User Interface:		
Front panel touch screen GUI	Yes	<i>Edit output, patterns, and instrument setup.</i>
Computer programmable Interface	Yes USB	

Ordering Information	
Model 12040	8Gb/s Programmable Pattern Generator
Model 12040-J	8Gb/s Programmable Pattern Generator with Jitter Insertion Option
Model 12050	12.5Gb/s Programmable Pattern Generator
Model 12050-J	12.5Gb/s Programmable Pattern Generator with Jitter Insertion Option

**Amplitude may be programmed between 250mV and 2V.
Crossing Point may be programmed from 35% to 65%.**

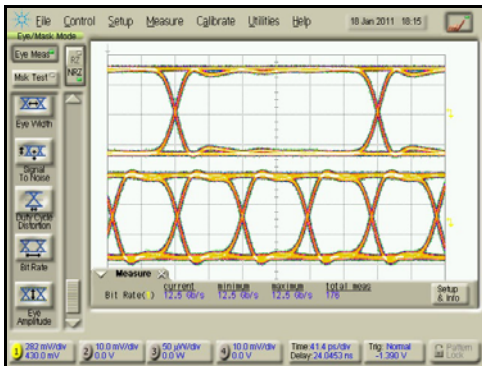


1V and 500mV programmed data outputs.

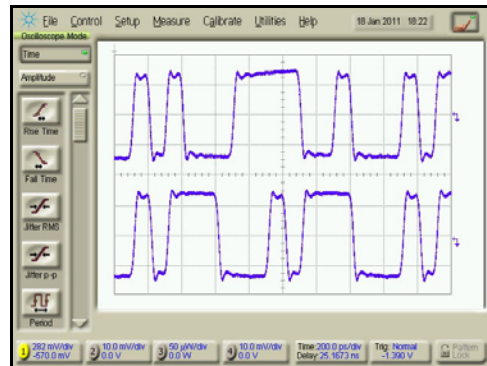


35% and 65% programmed data crossing point.

**Data rate may be programmed via an internal low jitter clock source.
Output may be either built-in PRBS patterns or programmed user data patterns.**

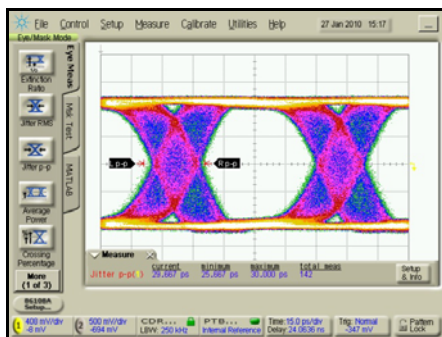


4Gb/s and 12.5Gb/s programmed data rates.

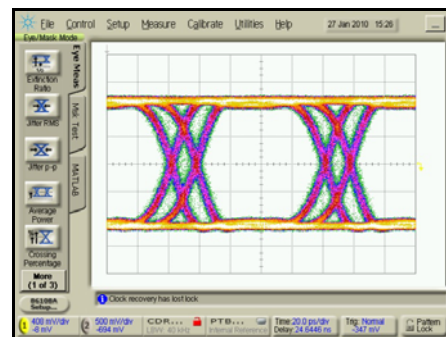


Built-in PRBS and programmed user data outputs.

**Jitter insertion option provides up to 200ps of jitter modulation amplitude.
Jitter modulation sources may be built-in sources (sine, random) or an external input.**



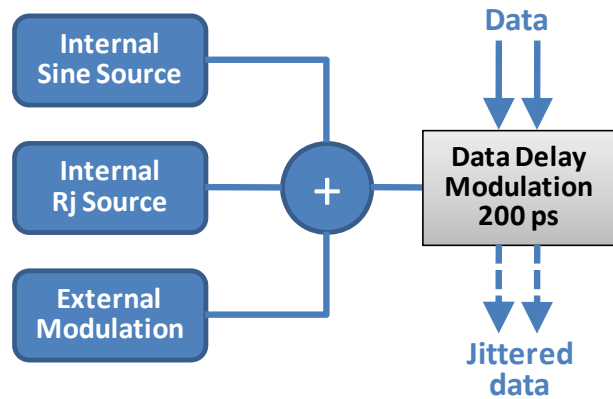
Stressed eye with built-in sinusoidal jitter insertion.



Stressed eye with external square wave modulation.

Jitter Insertion Option Information:

- **200 picoseconds of modulation range**
 - Equals 1.6 UI at 8 Gb/s
 - Equals 2.5 UI at 12.5 Gbps
- **Built-in sinusoidal modulation source**
- **Built-in random modulation source**
- **900MHz modulation bandwidth**
- **Input for external modulation sources**
- **Front panel touch screen GUI or USB remote control programming**



Jitter Insertion Option Block Diagram

The Picosecond Pulse Labs' **SDG Model 12040** (8GHz) or **SDG Model 12050** (12.5GHz) pattern generators may be ordered with a built-in jitter insertion option. This jitter insertion option provides an easy to use feature that can be programmed from within the pattern generator controls (touch screen GUI or USB/remote). Built-in modulation sources (random, sine) minimize the need for additional equipment and facilitate fast, efficient jitter tolerance testing.

Jitter Insertion Option Specifications:

Description:	Value/Details	Notes
Total modulation range	200 ps _{pk-pk}	Peak to peak range of jitter modulation for all sources combined (internal or external).
Built-in sine source Frequency range Maximum programmable amplitude	5 kHz to 200 MHz 200 ps _{pk-pk}	Programmable from either front panel touch screen GUI or remote control.
Built-in random noise modulation source Maximum programmable amplitude	25 ps RMS	Programmable from either front panel touch screen GUI or remote control.
External modulation input Frequency range Range Max input	1 kHz to 900 MHz 200 ps _{pk-pk} 2 V _{pk-pk}	AC coupled. 3 dB bandwidths. 2 V _{pk-pk} input equals modulation of 200 ps _{pk-pk} .

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